


<b>Search Notes</b>  	<b>Application/Control No.</b>  09632775	<b>Applicant(s)/Patent Under Reexamination</b>  KOSTOFF, II ET AL.
	<b>Examiner</b>  Lazaro, David	<b>Art Unit</b>  2155

SEARCHED			
Class	Subclass	Date	Examiner
709	227, 236, 237, 245	4/20/07	DRL
370	351, 392, 395.2, 395.54, 509, 514	4/20/07	DRL
709	227, 236, 237, 245	12/21/07	DRL
370	351, 392, 395.2, 395.54, 509, 514	12/21/07	DRL
709	236, 245	8/7/08	DRL
370	392, 509, 514	8/7/08	DRL

SEARCH NOTES		
Search Notes	Date	Examiner
EAST: USPAT, USPGPUB update	4/20/2007	DRL
EAST: USPAT, USPGPUB update	12/21/07	DRL
NPL: Google, Scirus, INSPEC, IEEE - keywords: checksum, FCS, crc, overhead, reduction, replacement, substitution	12/21/07	DRL
EAST: USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, FPRS - subject matter and inventor search	8/7/08	DRL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
709	236, 245	8/7/08	DRL
370	392, 514	8/7/08	DRL